

<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  (Use several sheets if necessary)			Docket Number (Optional) <b>20 02 1052-2</b>		Application Number <b>10/635198</b> Not yet assigned		
			Applicant <b>Harjung</b>				
			Filing Date <b>8/6/03</b> herewith		Group Art Unit <b>2125</b> Not yet assigned		
<b>U. S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<b>FOREIGN PATENT DOCUMENTS</b>							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
<i>Ans</i>	EP 1 128 293	29.08.01	Europe	—	—	X	
<b>OTHER DOCUMENTS</b> (including Author, Title, Date, Pertinent Pages, Etc.)							
<i>Ans</i>	Guingale, A., European Search Report Application No. EP 03 00 0829 dated 8 May 2003.						
<i>Ans</i>	Cory S.D. et al, "AUTOMATIC NETLIST EXTRACTION FOR MEASUREMENT-BASED CHARACTERIZATION OF OFF-CHIP INTERCONNECT," IEEE, October 1997, vol. 45, no. 10, pages 1934-1940.						
<i>Ans</i>	Novellino, J., "SYSTEM MEASURES AND MODELS INTERCONNECTS," Cleveland, Ohio, vo. 41, no. 6, 18 March 1993, page 122, 124 and 126.						
<i>Ans</i>	Hatden L.A. et al., "MEASUREMENT AND CHARACTERIZATION OF HIGH-SPEED INTERCONNECTIONS USING TIME DOMAIN NETWORK ANALYSIS," San Francisco, CA, October 1992, pages 144-149.						
EXAMINER  <i>Albert W. Paladini</i> <b>ALBERT W. PALADINI</b> <b>PATENT EXAMINER</b>				DATE CONSIDERED  <b>5-19-06</b>			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 5609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							